Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/001,761	AMON ET AL.
Examiner	Art Unit
Sean Reilly	2153

	SEARCHED				
Class	Subclass	Date	Examiner		
705	10, 14	10/27/2005	SR		
709	203, 219	10/27/2005	SR		
705	10,14	3/24/06	88 88		
709	203,219	3/24/06	87		
		,			

Class	Subclass	Date	Examiner
709	203,	3/24/06	82
705	10,14	3/24/06	87

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor and Assignee double patenting search	10/27/2005	SR		
See attached EAST text search	10/27/2005	SR		
Searched NPL: ACM, IEEE, Google.com, Google groups, citeseer.com, WSJ, Financial Times	10/27/2005	SR		
STIC 705 mandatory database search by Geoffrey St. Leger	10/27/2005	SR		
Consulted w/ Examiner Dinh	10/26/2005	SR		
Consulted w/ 705/14 Examiners Janes Myhre and Yehdega Retta	10/26/2005	SR		
Consulted w/ SPREs Brian Johnson and Vincent Trans	10/26/2005	SR		